## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | ZIV, TIDHAR | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0037490 A1	11-2001	Chiang, Hiang-Swee	717/2
*	В	US-2002/0065950 A1	05-2002	Katz et al.	709/318
*	C	US-2002/0188674 A1	12-2002	Brown et al.	709/203
*	D	US-2003/0085918 A1	05-2003	Beaumont et al.	345/738
*	E	US-2005/0251797 A1	11-2005	Omiya et al.	717/165
	F	US-			
	G	US-			
	Н	US-			
		US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				·	
	0					
	Р					
	α					
	R	_				
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	·
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.